

# SN54BCT25245, SN74BCT25245 25-Ω OCTAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS

SCBS053B – MAY 1990 – REVISED APRIL 1994

- State-of-the-Art BiCMOS Design Significantly Reduces  $I_{CCZ}$
- ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Designed to Facilitate Incident-Wave Switching for Line Impedances of 25 Ω or Greater
- Distributed  $V_{CC}$  and GND Pins Minimize Noise Generated by the Simultaneous Switching of Outputs
- Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK) and Flatpacs (W), and Standard Plastic and Ceramic 300-mil DIPs (JT, NT)

## description

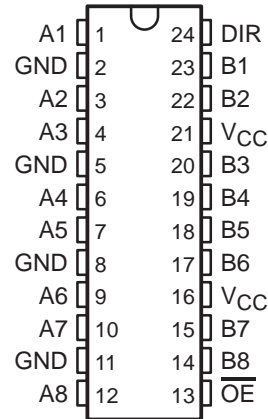
The 'BCT25245 is a 25-Ω octal bus transceiver designed for asynchronous communication between data buses. It improves both the performance and density of 3-state memory address drivers, clock drivers, and bus-oriented transceivers.

The device allows data transmission from the A bus to the B bus or from the B bus to the A bus depending upon the logic level at the direction-control (DIR) input. The output-enable ( $\overline{OE}$ ) input can disable the device so that both buses are effectively isolated.

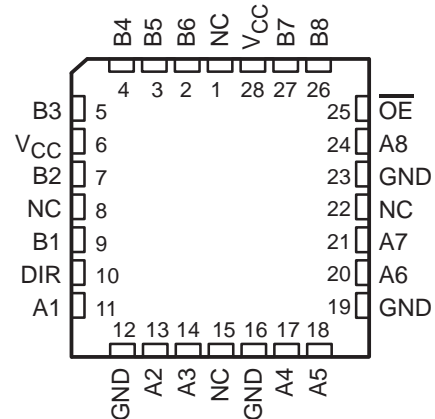
These transceivers are capable of sinking 188-mA  $I_{OL}$ , which facilitates switching 25-Ω transmission lines on the incident wave. The distributed  $V_{CC}$  and GND pins minimize switching noise for more reliable system operation.

The SN54BCT25245 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74BCT25245 is characterized for operation from 0°C to 70°C.

SN54BCT25245 . . . JT OR W PACKAGE  
SN74BCT25245 . . . DW OR NT PACKAGE  
(TOP VIEW)



SN54BCT25245 . . . FK PACKAGE  
(TOP VIEW)



NC – No internal connection

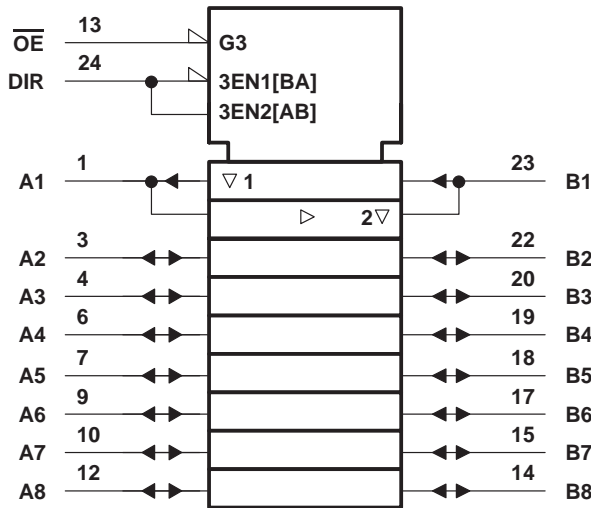
FUNCTION TABLE

INPUTS		OPERATION
$\overline{OE}$	DIR	
L	L	B data to A bus
L	H	A data to B bus
H	X	Isolation

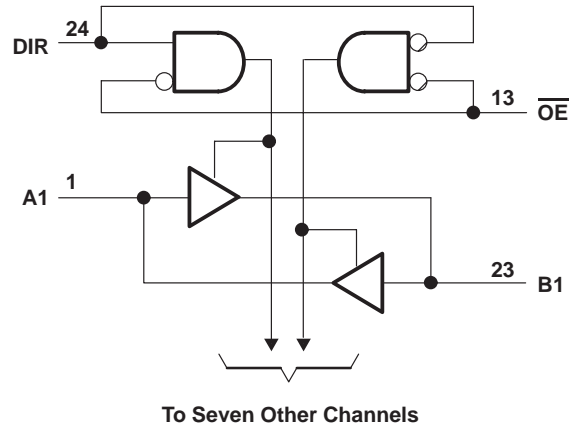
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## logic symbol†



## logic diagram (positive logic)



† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for the DW, JT, NT, and W packages.

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)‡

Supply voltage range, $V_{CC}$ .....	-0.5 V to 7 V
Input voltage range, $V_I$ (see Note 1): Control inputs .....	-0.5 V to 7 V
I/O ports .....	-0.5 V to 5.5 V
Voltage range applied to any output in the disabled or power-off state, $V_O$ .....	-0.5 V to 5.5 V
Voltage range applied to any output in the high state, $V_O$ (B port) .....	-0.5 V to $V_{CC}$
Input clamp current, $I_{IK}$ .....	-30 mA
Current into any output in the low state, $I_O$ : SN54BCT25245 (A port) .....	250 mA
SN54BCT25245 (B port) .....	40 mA
SN74BCT25245 (A port) .....	376 mA
SN74BCT25245 (B port) .....	48 mA
Operating free-air temperature range: SN54BCT25245 .....	-55°C to 125°C
SN74BCT25245 .....	0°C to 70°C
Storage temperature range .....	-65°C to 150°C

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

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## recommended operating conditions

		SN54BCT25245			SN74BCT25245			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
$V_{CC}$	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			2			V
$V_{IL}$	Low-level input voltage			0.8			0.8	V
$I_{IK}$	Input clamp current			-18			-18	mA
$I_{OH}$	High-level output current	A port		-53	B port		-80	mA
		B port		-3	A port		-3	
$I_{OL}$	Low-level output current	A port		125	B port		188	mA
		B port		20	A port		24	
$T_A$	Operating free-air temperature	-55	125		0	70		°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54BCT25245		SN74BCT25245		UNIT		
				MIN	TYP†	MAX	MIN		TYP†	MAX
$V_{IK}$		$V_{CC} = 4.5\text{ V}$ ,	$I_I = -18\text{ mA}$			-1.2		-1.2	V	
$V_{OH}$	A port	$V_{CC} = 4.5\text{ V}$	$I_{OH} = -53\text{ mA}$	2					V	
			$I_{OH} = -80\text{ mA}$			2				
		$V_{CC} = 4.75\text{ V}$ ,	$I_{OH} = -3\text{ mA}$				2.7			
	B port	$V_{CC} = 4.5\text{ V}$ ,	$I_{OH} = -3\text{ mA}$	2.4	3.3		2.4	3.3		
$V_{OL}$	A port	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 94\text{ mA}$		0.38	0.55		0.42	0.55	V
			$I_{OL} = 125\text{ mA}$				0.8			
			$I_{OL} = 188\text{ mA}$						0.7	
	B port	$V_{CC} = 4.5\text{ V}$	$I_{OL} = 20\text{ mA}$		0.3	0.5				
$I_{OL} = 24\text{ mA}$							0.35	0.5		
$I_I$	A or B port	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 5.5\text{ V}$			0.25		0.25	mA	
	Control input					0.1		0.1		
$I_{IH}‡$	A or B port	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 2.7\text{ V}$			70		70	μA	
	Control input					20		20		
$I_{IL}‡$	A or B port	$V_{CC} = 5.5\text{ V}$ ,	$V_I = 0.5\text{ V}$			-0.6		-0.6	mA	
	Control input					-0.6		-0.6		
$I_{OS}§$	B port only¶	$V_{CC} = 5.5\text{ V}$ ,	$V_O = 0$	-60	-150		-60	-150	mA	
$I_{CCH}$	A to B	$V_{CC} = 5.5\text{ V}$		36	46		36	46	mA	
	B to A			63	80		63	80		
$I_{CCL}$	A to B	$V_{CC} = 5.5\text{ V}$		48	60		48	60	mA	
	B to A			95	125		95	125		
$I_{CCZ}$		$V_{CC} = 5.5\text{ V}$		12	16		12	16	mA	
$C_i$	Control input	$V_{CC} = 5\text{ V}$ ,	$V_I = 2.5\text{ V}$ or $0.5\text{ V}$			8		8	pF	
$C_{io}$	A port	$V_{CC} = 5\text{ V}$ ,	$V_O = 2.5\text{ V}$ or $0.5\text{ V}$			18		18	pF	
	B port					8		8		

† All typical values are at  $V_{CC} = 5\text{ V}$ ,  $T_A = 25^\circ\text{C}$ .

‡ For I/O ports, the parameters  $I_{IH}$  and  $I_{IL}$  include the off-state output current.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

¶ Testing for this parameter on the A port is not recommended.

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## switching characteristics (see Note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, C <sub>L</sub> = 50 pF, R <sub>1</sub> = 500 Ω, R <sub>2</sub> = 500 Ω, T <sub>A</sub> = 25°C			V <sub>CC</sub> = 4.5 V to 5.5 V, C <sub>L</sub> = 50 pF, R <sub>1</sub> = 500 Ω, R <sub>2</sub> = 500 Ω, T <sub>A</sub> = MIN to MAX†				UNIT
			BCT25245			SN54BCT25245		SN74BCT25245		
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A	B	1.2	3.3	5.1	1.2	5.8	1.2	5.7	ns
t <sub>PHL</sub>			1.9	4.3	6.7	1.9	7.6	1.9	7.2	
t <sub>PLH</sub>	B	A	1.2	3.3	4.8	1.2	5.7	1.2	5.5	ns
t <sub>PHL</sub>			2.1	4	5.6	2.1	6.4	2.1	6.2	
t <sub>PZH</sub>	$\overline{OE}$	A	3.7	6.3	8.4	3.7	10.1	3.7	9.6	ns
t <sub>PZL</sub>			4.5	7.4	9.2	4.5	11.1	4.5	10.3	
t <sub>PHZ</sub>	$\overline{OE}$	A	1.8	3.7	5.5	1.8	6.4	1.8	6.2	ns
t <sub>PLZ</sub>			3.3	5.1	7.2	3.3	9.6	3.3	8.3	
t <sub>PZH</sub>	$\overline{OE}$	B	3.4	5.7	7.9	3.4	9.2	3.4	8.9	ns
t <sub>PZL</sub>			4.3	6.6	8.7	4.3	10.1	4.3	9.7	
t <sub>PHZ</sub>	OE	B	2.7	4.5	6.3	2.7	7.2	2.7	6.9	ns
t <sub>PLZ</sub>			1.7	4.5	6.8	1.7	8.3	1.7	7.5	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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